

FORM PTO-1449

US DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

DEC 18 2001

Atty. Docket No.

83489DMW

Customer No. 01333

Serial No.

US 09/994,096

If AFTER the later date of the first Office action or 3 months from filing, use only with Rule 97(E) Certificate or Fee

## LIST OF ART CITED BY APPLICANT

(Use several sheets if necessary)

Filing Date

26 November 2001

Group

## U.S. PATENT DOCUMENTS

Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
CV	USSN 09/740,562		Shoupu Chen et al.			12/19/00
CV	USSN 09/740,422		Shoupu Chen et al.			12/19/00
CV	5,432,863	7/11/95	Paul J. Benati et al.	382	167	7/19/93
CV	6,072,892	6/6/00	Seong-Beom Kim	382	117	4/3/98
CV	6,292,574	9/18/01	Jay S. Schildkraut et al.	382	117	8/29/97

## FOREIGN PATENT DOCUMENTS

Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES   NO

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

CV	"Distance to an Ellipsoid" by John C. Hart. Graphics Gems IV, Paul S. Heckbert, Editor, Academic Press, Boston, MA, pp. 113-119.
CV	"Active shape Models--Their Training and Application" by T.F. Cootes, C.J. Taylor, D.H. Cooper, and J. Graham. Computer Vision and Image Understanding, Vol. 61, No. 1, pp. 38-59, 1995.

EXAMINER

DATE CONSIDERED

9/17/04

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		DEC 10 2003 U.S. PATENT & TRADEMARK OFFICE JULY 2004	Atty. Docket No. 83489RLW Customer No. 01333	Serial No. 09/994,096
If AFTER the later date of the first <del>Office Action</del> or 3 months from filing, use only with Rule 97(E) Certificate or Fee		Applicant: Shoupu Chen, et al		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)		Filing Date 26 November 2001	Group 2621	
U.S. PATENT DOCUMENTS				
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS    SUBCLASS    FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES   NO
CL	0 899 680 A	3/3/1999	EP			
CL	97 211 88 A	6/12/1997	WO			
CL	1 229 493 A	8/7/2002	EP			

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
CL	Saber E. et al., "Face Detection and Facial Feature Extraction Using Color, Shape and Symmetry-based Cost Functions" Proceedings of the International Conference on Pattern Recognition, XX, XX, Vol. 3, 1996, pages 654-658, XP000863534 paragraph '0002.					
CL	Chow G. et al., "Towards a System for Automatic Facial Feature Detection" Pattern Recognition, Pergamon Press Inc. Elmsford, NY, US, Vol. 26, No. 12, 1 December 1993 (1993-12-01), pages 1739-1755, XP000420368; ISSN: 0031-3208, paragraph '03.1 - paragraph '03.2.					

EXAMINER		DATE CONSIDERED	9/7/04
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